

Application No.	Applicant(s)
10/612,940	TANAKA ET AL.
Examiner	Art Unit
Jean F. Duverne	2839

	SEAR	CHED	
Class	Subclass	Date	Examiner
385	113	6/20/2004	JFD
	100-114	6/20/2004	JFD
607	36	6/20/2004	JFD
	93	6/20/2004	JFD
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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